/	and so	PAIENI
AUG 3 1	AUG 3 1 2005 [5] IN THE UNITED STATES PATENT AND TRADEMARK OFFICE	
FEAT & TRAC	<u>In re</u> application of:) Docket No: LAM2P421
	Kiermasz et al.) Examiner: Rachuba, M. T.
	Application No: 10/607,613) Oroup Art Unit: 3723
•	Filed: June 27, 2003) Date: August 29, 2005
	For: PLATEN WITH DIAPHRAGM AND M FOR OPTIMIZING WAFER POLISHIN	,
09/01/2005 SH 01 FC:1801	ASSEN1 00000048 10607613 790.00 OP	CERTIFICATE OF MAILING I hereby certify that this correspondence is being deposited with the United States Postal Service as First Class Mail to: Commissioner for Patents, Alexandria, VA 22313-1450, on August 29, 2005. Signed: Kay Harlow
	REQUEST FOR CONTINUED EXAM	IINATION (RCE) TRANSMITTAL
	Mail Stop: RCE, Commissioner for Patents, Alexandria, VA 22313-1450	
	Sir:	
	This is a Request for Continued Examination (RCE) under 37 CFR 1.114 of the above-identified application.	
	1. Submission required under 37 C.F.R. § 1.114 a.	
		Chester E. Martine, Jr.
		Degistration No. 10.71/1

Registration No. 19,71/1 Customer No. 25920